EE 301 : Microelectronic Circuits II

Lecture 3

Building Blocks of Integrated Circuits

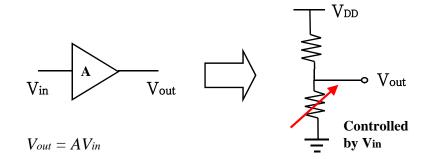
March 9, 2005

Prof. SeongHwan Cho

EE301 1

How to design a gain element

When we are going to design amplifiers for a varying gain, what is the simplest way?



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Outline

Transistor

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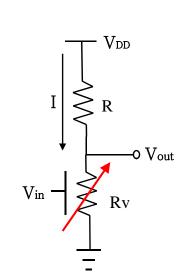
Semiconductor fundamentals

MOS Transistor

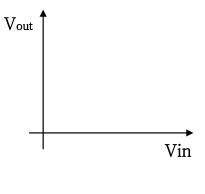
BJT

Variable Resistor

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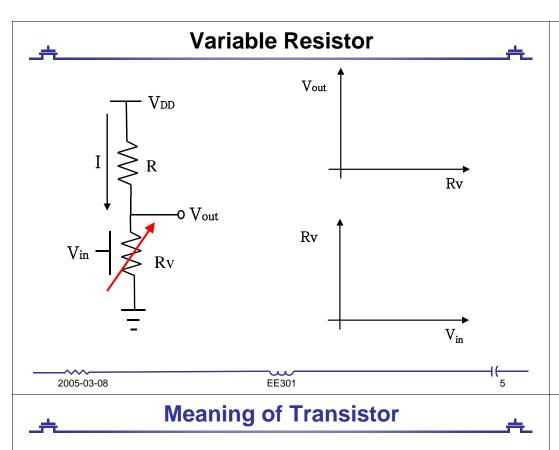


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$$V_{out} = \frac{R_{v}}{R + R_{v}} V_{DD}$$

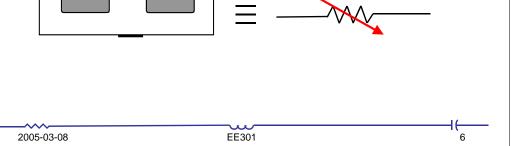
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How to design a gain element

By similar approach, we can also derive an exponential relation between V_{in} and V_{out}. In this case, you can see the characteristic of BJT.

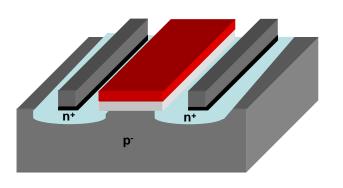
$$R_{_{V}} \propto \frac{1}{V_{_{in}}}$$



Structure of MOS Transistor

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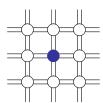


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Fundamentals of Semiconductor Energy Bands • Si: $14 \rightarrow 1s^2 2s^2 2p^6 3s^2 3p^2$ Valence Electrons Econduction Evalence Electron - hole pair 1s EE301 EE301 2005-03-08 2005-03-08 Si in Crystal **Energy Bands of Different Materials** Insulator Semi-conductor Conductor Energyband Free Electrons: EE301 EE301 2005-03-08 2005-03-08

Adding Impurities

At room temperature, $n_i \sim= 10^{10}/\text{cm}^3$, # of atoms = $10^{22}/\text{cm}^3$ \rightarrow one out of _____ atoms is ionized at room temperature.



p, p+, pn, n+, n-

P-N Junction



Diffusion:

Drift:

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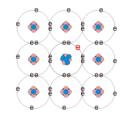
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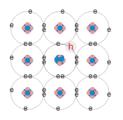
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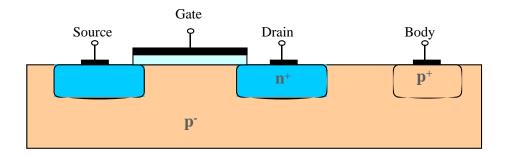
Doped semiconductors







Operation of MOS Transistor



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Linear Region: $I_{\rm D} = \mu_{\rm n} C_{ox} \frac{W}{L} \left[(V_{\rm GS} - V_{\rm T}) V_{\rm DS} - \frac{1}{2} V_{\rm DS}^2 \right]$

Saturated Region: $I_{\rm D} = \frac{1}{2} \mu_{\rm n} C_{\rm ox} \frac{W}{L} \left[\left(V_{\rm GS} - V_{\rm T} \right) V_{\rm DS} - \frac{1}{2} V_{\rm DS}^{2} \right]$

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Intuitive Understanding of I-V

$$I = v \cdot Q$$

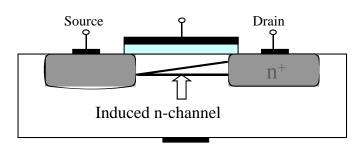
$$Q = CV$$

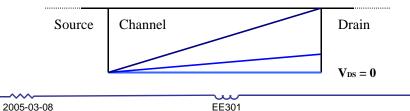
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Operation of MOS Transistor

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3. Operation as V_{DS} is increased



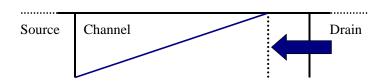


2nd order Effect : Channel Length Mod.

4. Operation as V_{DS} is increased beyond V_{DSsat}



Channel length modulation occurs,



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Operation of MOS Transistor

